

- ★ Green Device Available
- ★ Super Low Gate Charge
- ★ Excellent CdV/dt effect decline
- ★ Advanced high cell density Trench technology

Product Summary



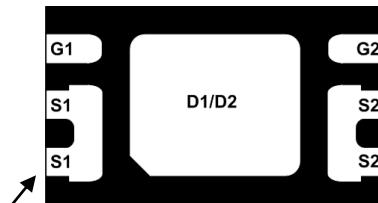
BVDSS	RDS(ON)	ID
20V	7.2mΩ	11A

General Description

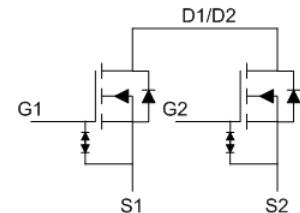
The FKCC8233 is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent RDS(ON) and gate charge for most of the small power switching and load switch applications.

The FKCC8233 meet the RoHS and Green Product requirement with full function reliability approved.

DFN2x3 Pin Configuration



Pin1



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	20	V
V _{GS}	Gate-Source Voltage	±12	V
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ 4.5V ¹	11	A
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ 4.5V ¹	8.8	A
I _{DM}	Pulsed Drain Current ²	70	A
P _D @T _A =25°C	Total Power Dissipation ¹	1.56	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-Ambient ¹ (t ≤10s)	---	80	°C/W



FETek Technology Corp.

FKCC8233

Dual N-Ch Fast Switching MOSFETs

N-Channel Electrical Characteristics ($T_J=25^\circ C$, unless otherwise noted)

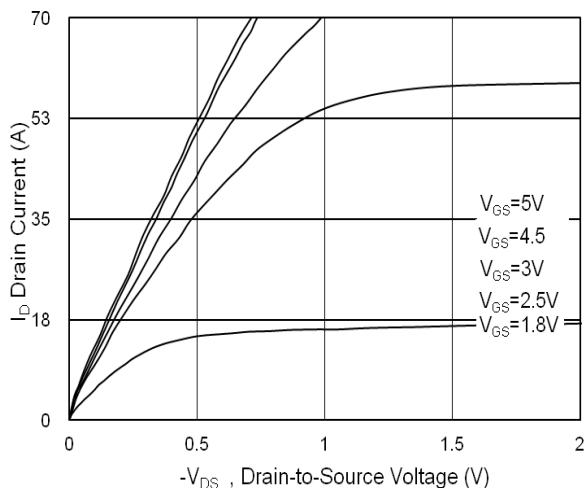
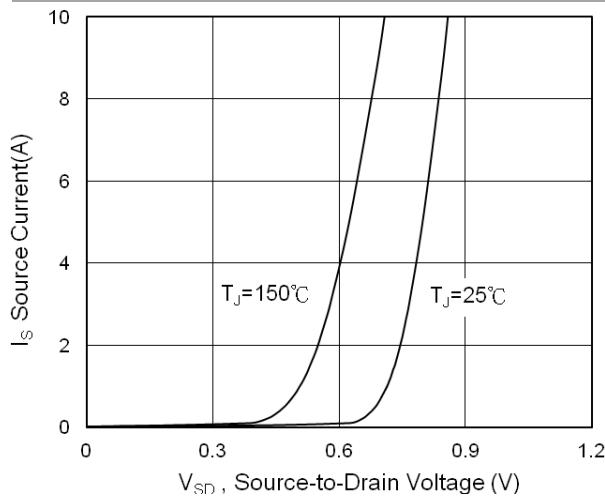
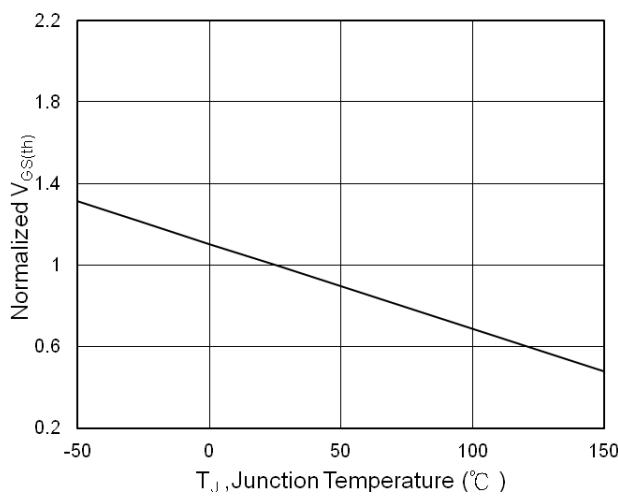
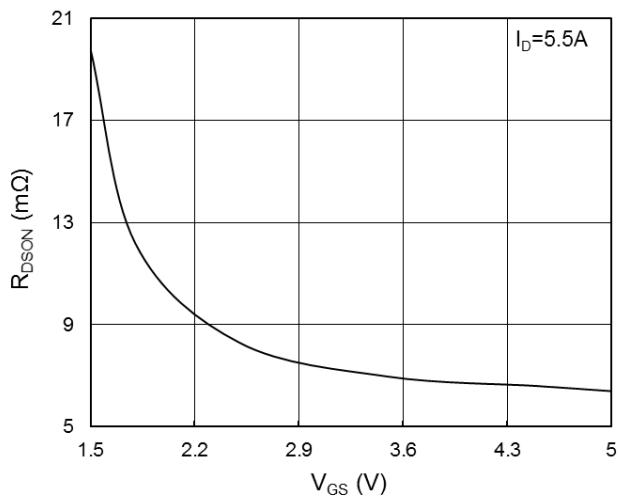
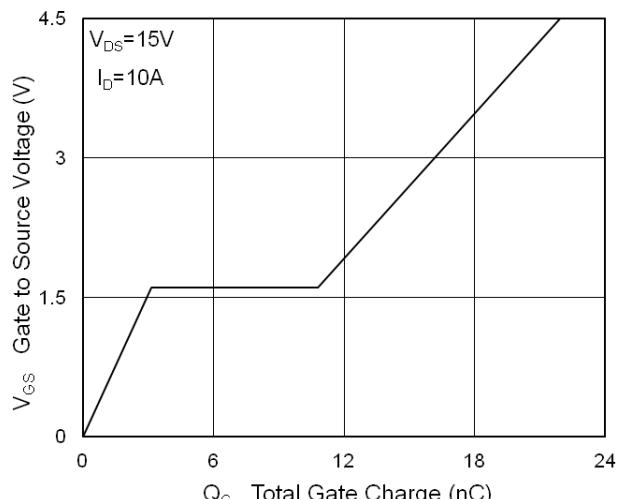
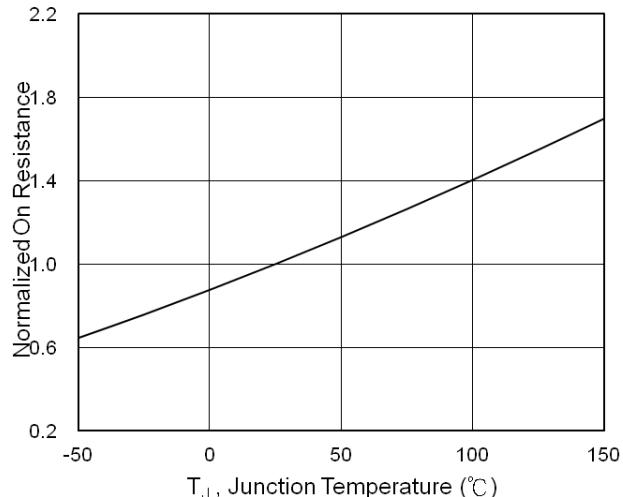
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	20	---	---	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance ²	$V_{GS}=4.5V, I_D=5.5A$	4.5	6	7.2	$m\Omega$
		$V_{GS}=4.0V, I_D=5.5A$	4.8	6.2	7.5	
		$V_{GS}=3.7V, I_D=5.5A$	5.0	6.5	8.2	
		$V_{GS}=3.1V, I_D=5.5A$	5.3	7	9	
		$V_{GS}=2.5V, I_D=5.5A$	6	8.2	10.2	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\mu A$	0.5	---	1.5	V
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=18V, V_{GS}=0V, T_J=25^\circ C$	---	---	1	μA
		$V_{DS}=18V, V_{GS}=0V, T_J=55^\circ C$	---	---	5	
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 12V, V_{DS}=0V$	---	---	± 10	μA
g_{fs}	Forward Transconductance	$V_{DS}=5V, I_D=5.5A$	---	38	---	S
Q_g	Total Gate Charge (4.5V)	$V_{DS}=16V, V_{GS}=4.5V, I_D=10A$	---	23	---	nC
Q_{gs}	Gate-Source Charge		---	3.5	---	
Q_{gd}	Gate-Drain Charge		---	8.4	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{DD}=16V, V_{GS}=4.5V, R_G=6\Omega$	---	10.2	---	ns
T_r	Rise Time		---	41	---	
$T_{d(off)}$	Turn-Off Delay Time		---	67	---	
T_f	Fall Time		---	31	---	
C_{iss}	Input Capacitance	$V_{DS}=10V, V_{GS}=0V, f=1MHz$	---	1767	---	pF
C_{oss}	Output Capacitance		---	184	---	
C_{rss}	Reverse Transfer Capacitance		---	155	---	

Diode Characteristics

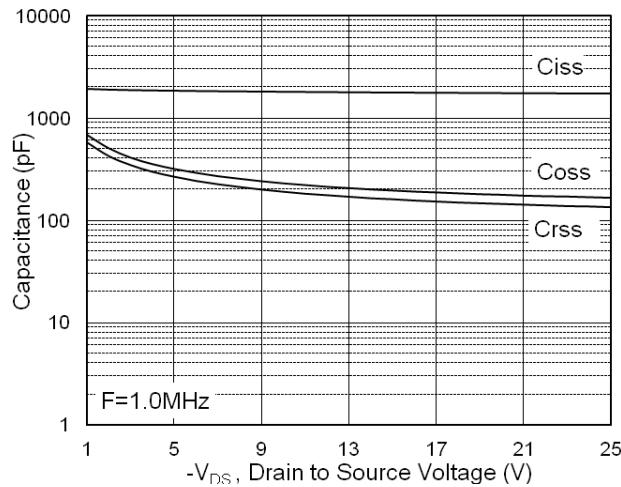
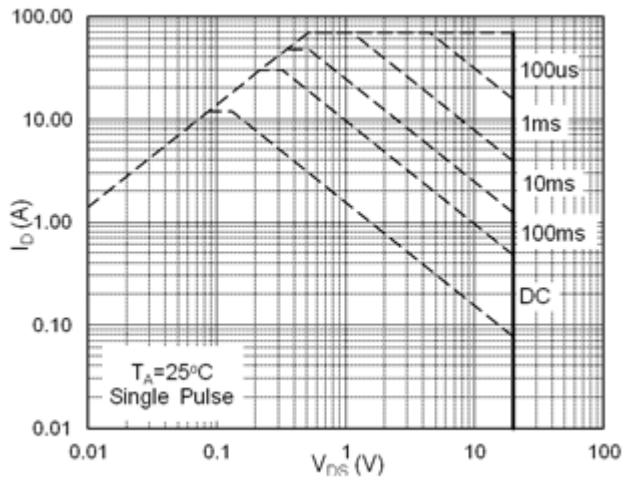
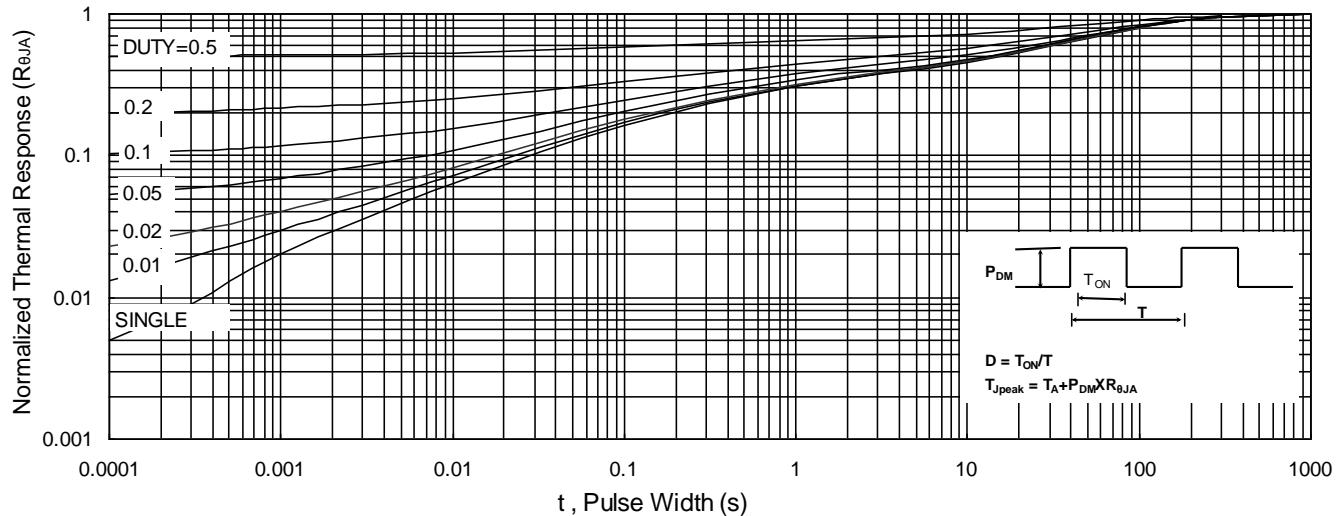
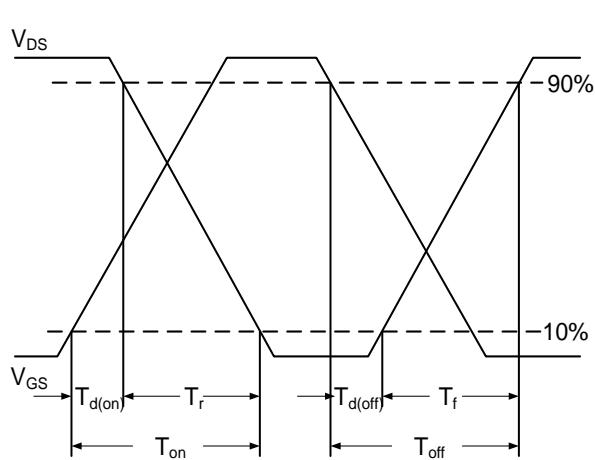
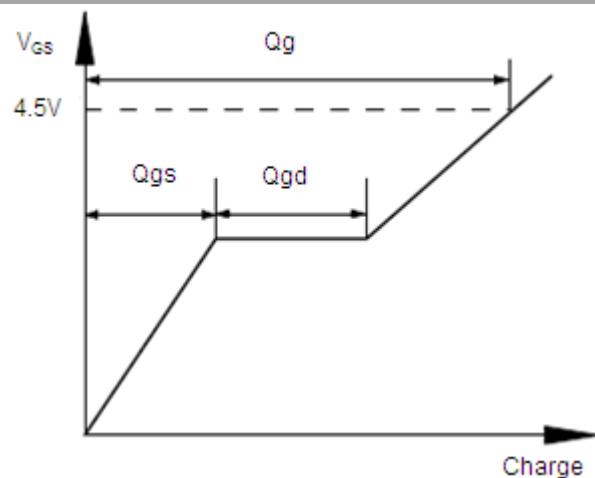
Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current ¹	$V_G=V_D=0V$, Force Current	---	---	11	A
I_{SM}	Pulsed Source Current ²		---	---	70	A
V_{SD}	Diode Forward Voltage ²	$V_{GS}=0V, I_S=11A, T_J=25^\circ C$	---	---	1.2	V

Note :

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, $t \leq 10s$.
- 2.The data tested by pulsed , pulse width $\leq 10\mu s$, duty cycle $\leq 1\%$

Typical Characteristics

Fig.1 Typical Output Characteristics

Fig.3 Forward Characteristics of Reverse

Fig.5 $V_{GS(th)}$ vs. T_J

Fig.2 On-Resistance vs. Gate-Source

Fig.4 Gate-Charge Characteristics

Fig.6 Normalized $R_{DS(on)}$ vs. T_J

Data and specifications subject to change without notice.
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Fig.7 Capacitance

Fig.8 Safe Operating Area

Fig.9 Normalized Maximum Transient Thermal Impedance

Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform